

Figure S1: XPS depth profile of as-received Ti-6Al-4V sample.

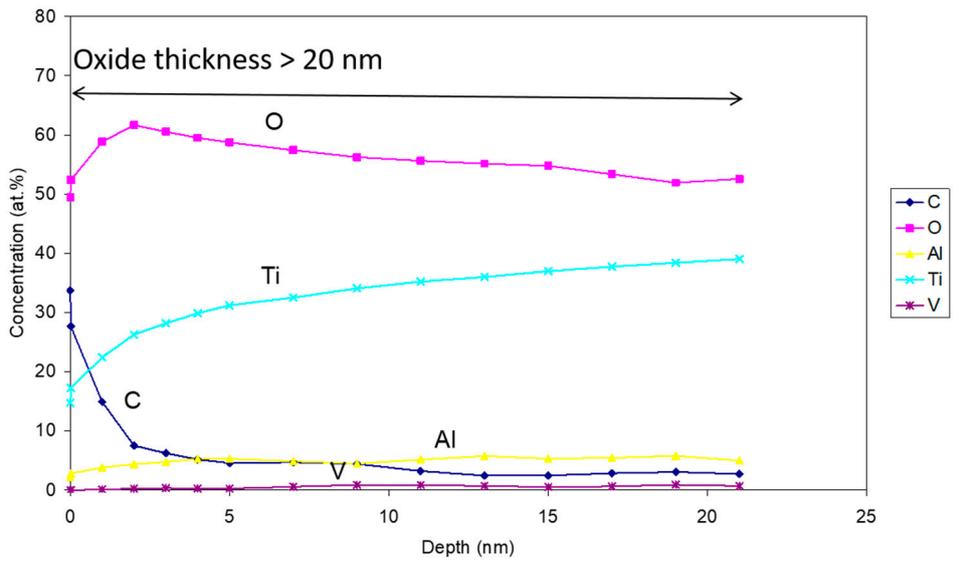


Figure S2: XPS depth profile of laser-textured Ti-6Al-4V sample with  $\Delta x = 100 \mu\text{m}$ .